

Engineering Radiation Monitor (ERM)

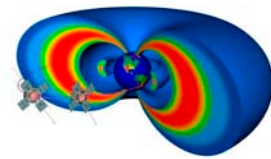
J. Goldsten



This document has been reviewed and approved for public release



Purpose

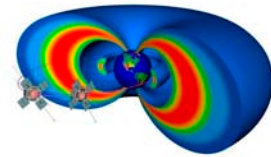


The Engineering Radiation Monitor (ERM) will monitor total dose and deep-dielectric charging at each RBSP spacecraft in real time

- In-situ monitoring enables correlation of spacecraft anomalies with space weather conditions
- IC RadFET sensors have same sensitive micro-volume as most s/c electronic devices and therefore “see” same effects
 - Sensitive to all types of ionizing dose
 - Unique opportunity to cross-compare with Aerospace dosimeter
- Spacecraft charging monitor detects penetrating electrons
 - Monitors potentially hazardous charge build up on dielectrics within the s/c (e.g., circuit boards and coaxial cables)
 - Reports energetic electron environment, which may be highly localized
- Provides valuable data for future missions
 - Validation of space environment models and transport codes
 - Design of other high radiation missions (e.g., Jupiter moons)



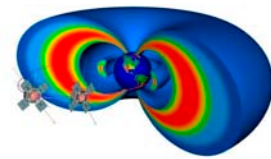
Origin



- Conceived as a balance mass experiment to recover S/C capability lost during early cost-cutting efforts
 - Dosimeter
 - Deep dielectric discharge monitor
- Power and data I/F available via RBSPICE test port
- Not required for mission success
 - No Mission Level 1 requirements
 - Waiver granted for relaxed parts and documentation requirements
 - Best practices followed where possible
 - Full pedigree parts for interface to RBSPICE (“do no harm”)
 - FMEA performed on first circuits
- Flight units successfully integrated on S/C A and B



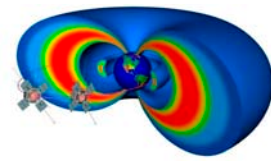
Conops/Resources



- ERM powered on/off via RBSPICE command
 - Off by default
 - RBSPICE autonomy will turn off ERM if current limit exceeded
- Dosimeter operated in unbiased mode; whenever ERM is powered off, it continues to accumulate dose accurately until the next time ERM is powered on
- ERM has only one operating mode: continuously cycle through readings every 3 minutes
 - RBSPICE reads and packetizes data with unique APID
 - Telemetry packets available via the MOC and RBSPICE SOC
- Telemetry fixed at 16 bps
- Mass: 2.9 kg
- Power: 250 mW
- Envelope: 18 x 18 x 6 cm³



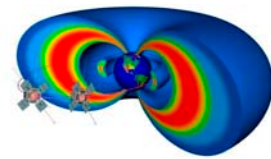
Measurement Objectives/Requirements



- Dosimeter
 - Provide multiple measurements along the dose depth curve
 - Sufficient dynamic range for >2-yr mission
 - Sufficient sensitivity and temporal resolution to profile orbit (electron vs. proton dose)
- Charge Monitor
 - Sufficient dynamic range to handle worst-case storm w/o saturating
 - Sufficient sensitivity to gauge quiescent conditions
 - Sufficient temporal resolution to monitor dynamics
 - Provide crude spectrometry using dual thickness cover

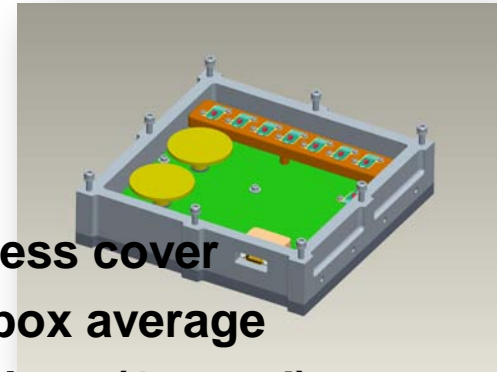


Sensors



- **Dosimeter**

- Array of RadFETs provides dose depth curve
- 7 RadFET “pixels” mounted under varying thickness cover
- 8th RadFET mounted directly to board measures box average
- Each RadFET die actually contains 2 RadFET devices (16 total)
 - Can average readings to reduce statistical uncertainty
 - Potentially improves calibration
- Wide dynamic range (0 to 1000 krad) with <0.1 krad sensitivity
- Initial sensitivity <0.01 krad is sufficient to profile orbit

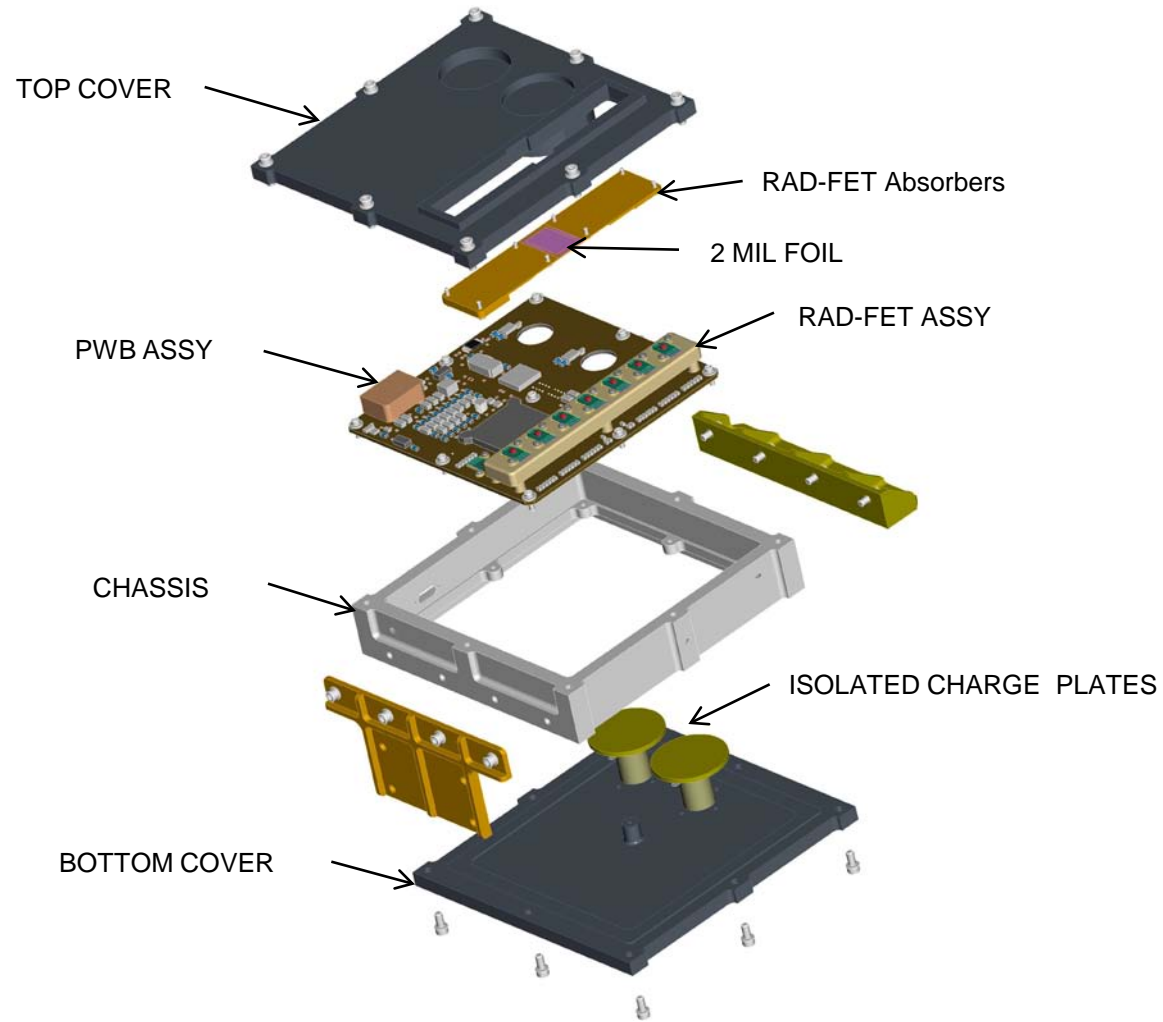
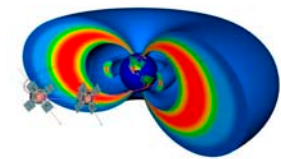


- **Charge Monitors**

- Two large-area sensors (~10 cm²) behind different cover shielding
- Wide dynamic range (0 to 30 pA) with < 0.01 pA sensitivity
- High time resolution (5 sec) to characterize rapid changes in flux, or can be time-averaged to increase sensitivity

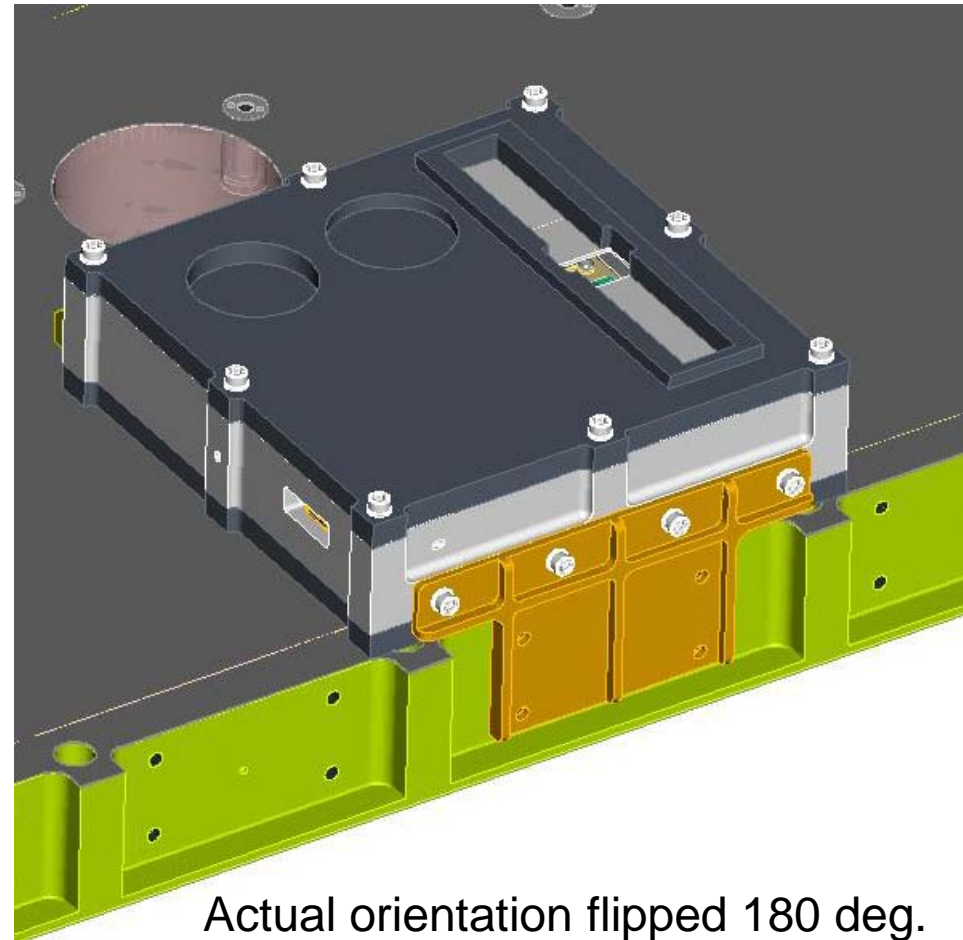
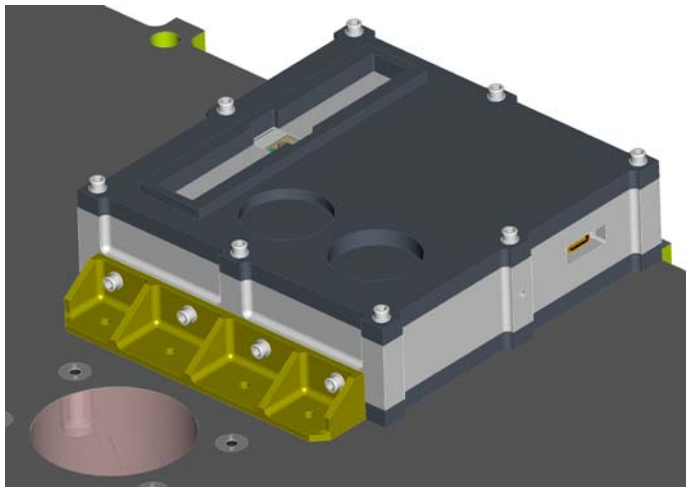
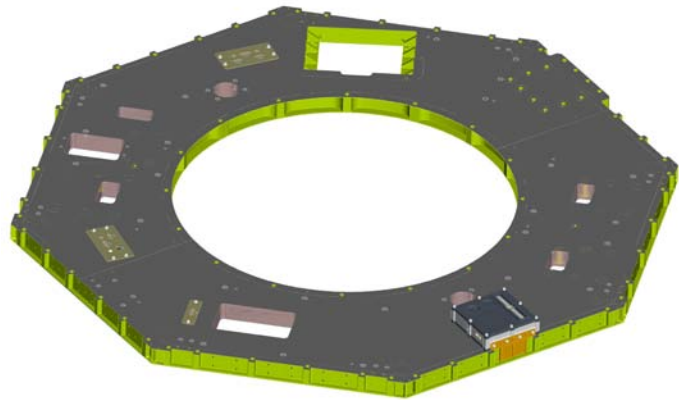
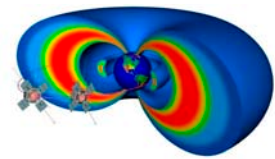


Assembly





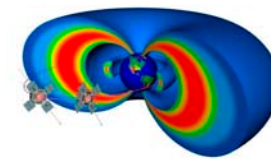
S/C Location



Actual orientation flipped 180 deg.
for easier cable access

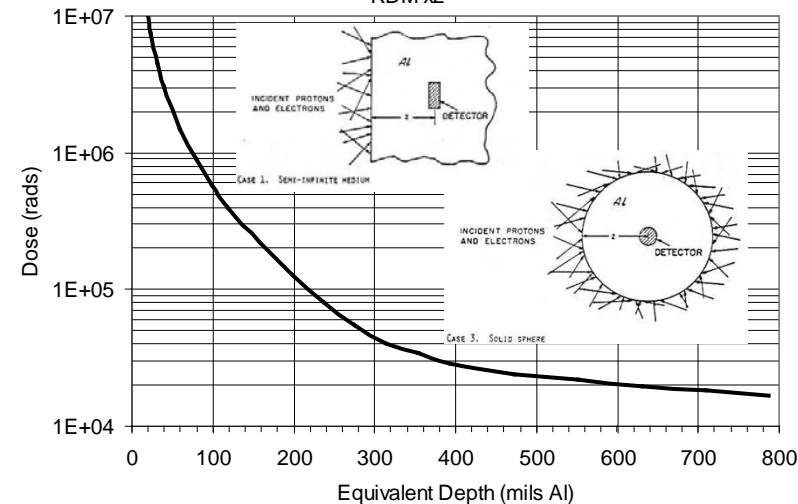


Simulating the ERM in the RBSP Radiation Environment

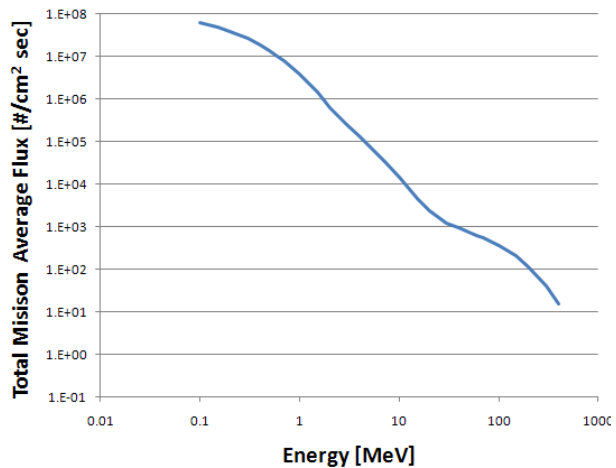


- Previous simulations assumed simple geometries (slab and sphere)
- Geant4 used to create a high fidelity simulation of the ERM to predict the actual response of the RadFETs and charge collection plates
- Simulation results used to optimize cover design

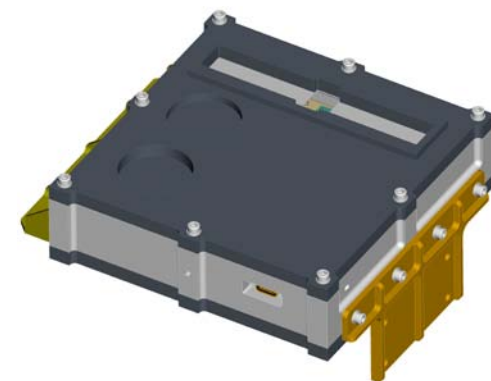
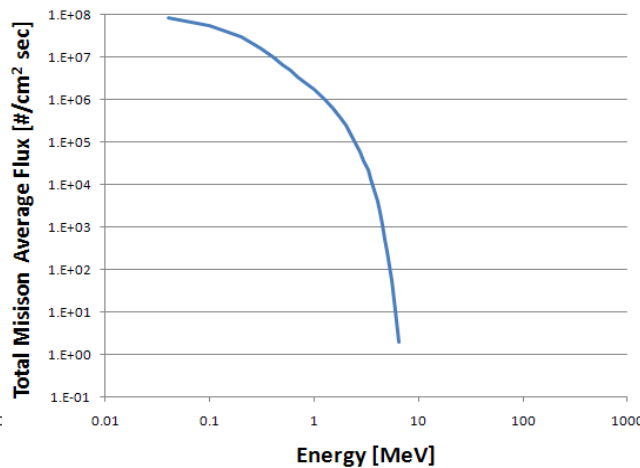
RBSP Mission Dose Depth Curve
2 Years, 75 Days
RDM x2



Proton Flux (SPENVIS 4.5.0)

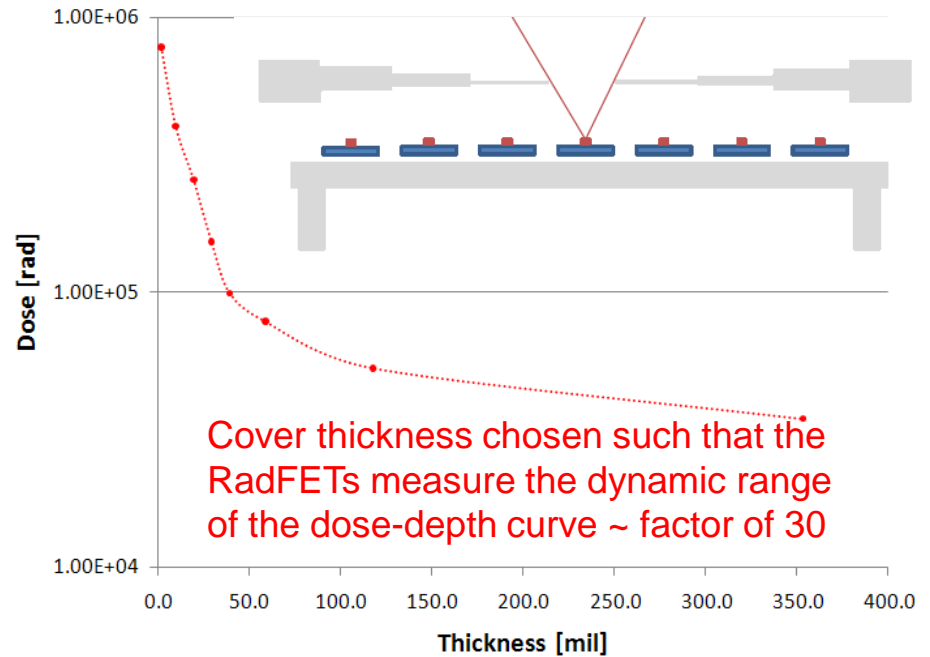
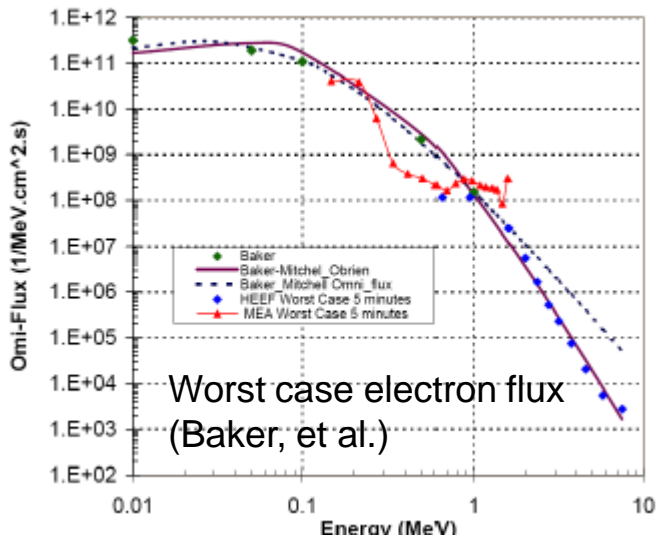
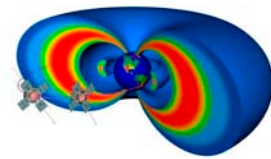


Electron Flux (SPENVIS 4.5.0)

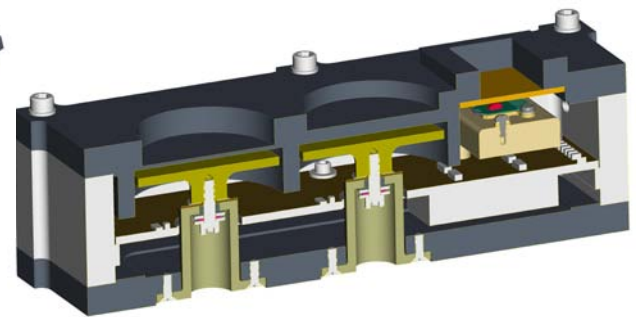
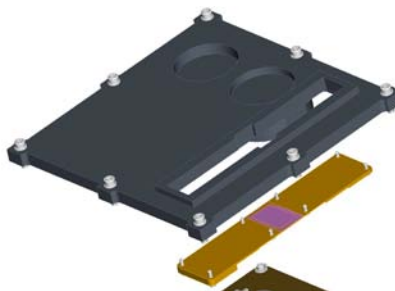




Cover Design

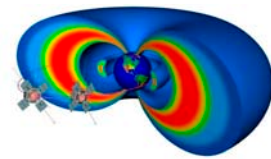


- Charge collection plates mounted close to cover to maximize solid angle (~50%)
- Side shielding added to reduce “background” electrons
- Collected signal ~10 pA for 3.8-cm dia. charge plate

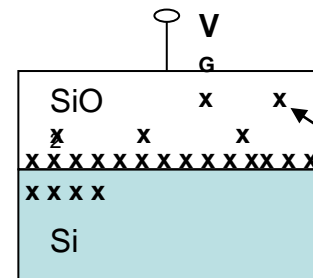
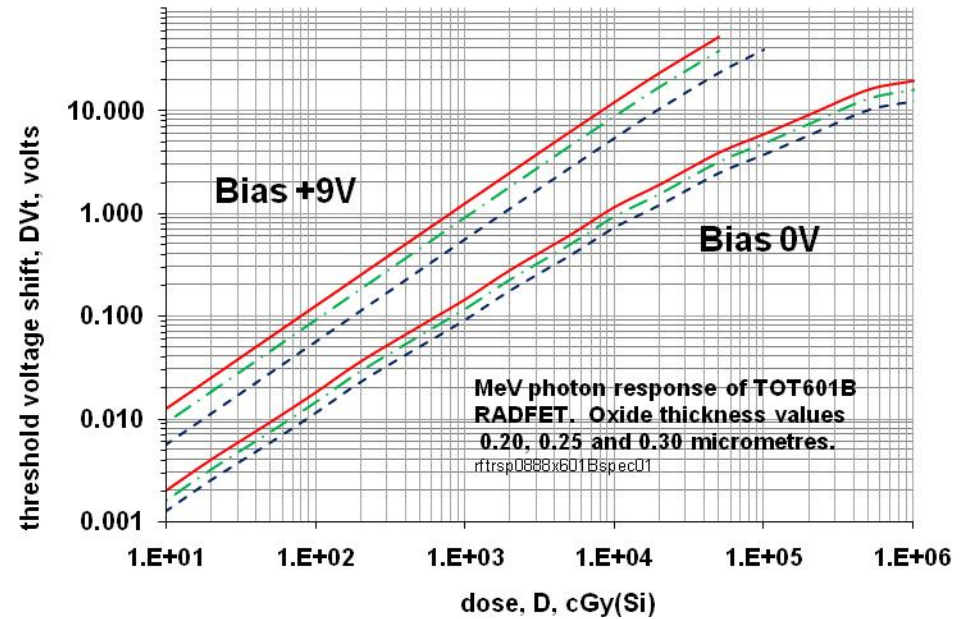




RadFET Response



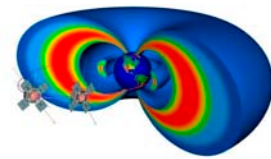
- RadFETs are p-MOSFET transistors with thickened gate oxide region
- Radiation-induced charge in the insulated gate oxide (SiO₂) region remains trapped
- Induced charge produces a threshold voltage shift vs. dose
- Thicker oxide region increases sensitivity; thinner one increases dynamic range
- LET response; Not overly affected by dose rate or particle species
- Long-term fade (self-annealing) is potentially a calibration issue, but may be less of a problem if operated cold



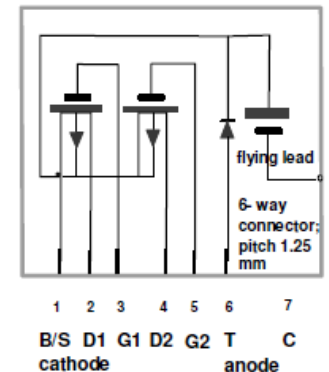
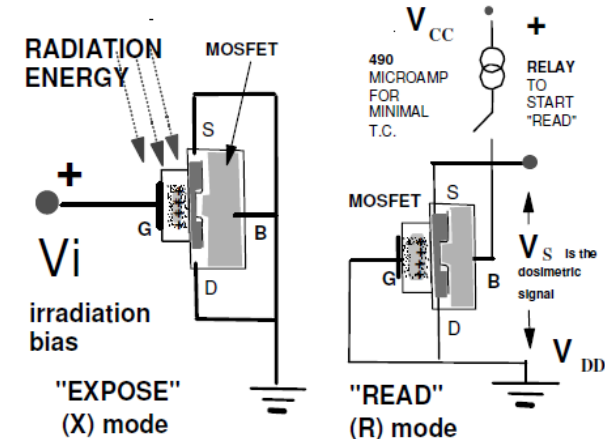
www.RADFET.com COPYRIGHT REM 2005



RadFET Operation

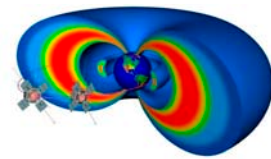


- RadFET biased at 0V during exposure
 - Calibration accurate when powered off
 - Extends dynamic range to 1 Mrad w/ 30V supply
 - Response less linear than if biased
- Source pin connected to constant current source during read cycle
 - Read time kept to ~1% duty cycle to maintain calibration
 - Readings captured at 1 and 2 sec following application of bias to characterize “drift up” effect
 - Readings at two different currents to measure device gain
 - On-chip diode used to monitor die temp
- Everything changes with dose! Careful calibration required
 - All devices from same lot
 - EM unit can be used for additional ground calibrations post-launch

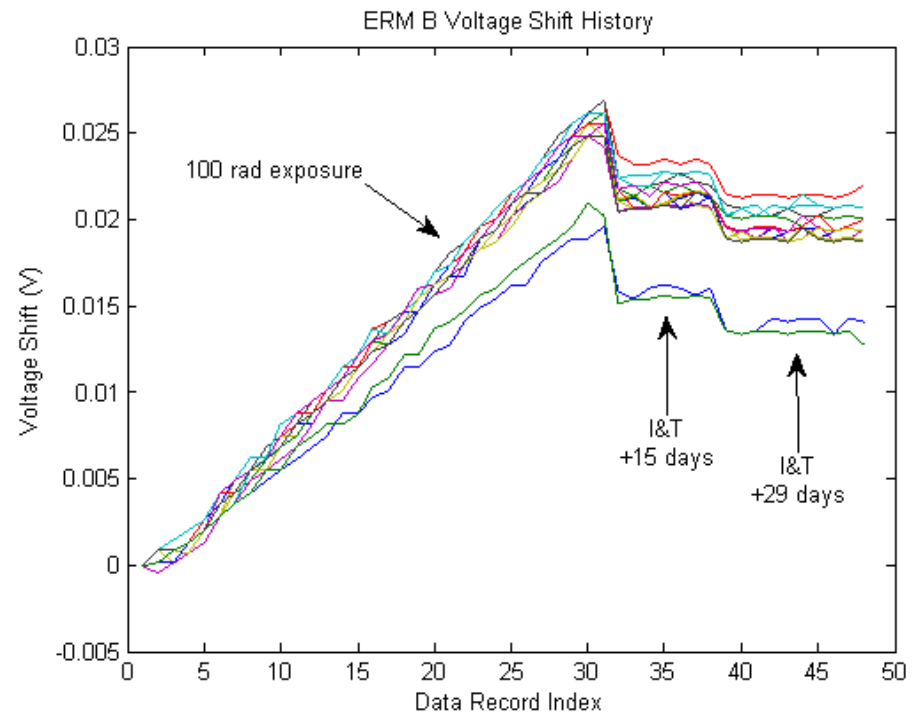




Calibration



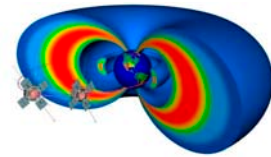
- Each flight unit irradiated w/o cover to expose all RadFETs
- Spread between bench-mounted RadFETs is +/- 5%.
- Initial data can be used to improve die-to-die matching and reduce spread further
- Long-term fade is clearly a cal issue for unbiased RadFETs at room temperature; Colder operation may help
- Low dose-rate test in progress using EM (60-day test at expected mission dose rate)
- Tests w/ particle beams planned next summer



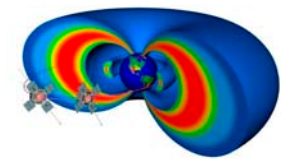
ERM-A in Co-60 Irradiator



Other Uses



- Possible uses of ERM data by the SWG



Backup



Block Diagram

